

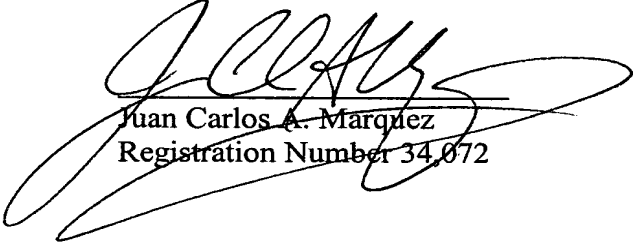
It is hereby certified that each item of information contained in this statement was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.

The Examiner is requested to acknowledge consideration of the information provided in this paper in accordance with prescribed procedures.

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	NOZAKI et al.	
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U.S. Patent Documents

Examiner Initial		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE

Foreign Patent Documents

Examiner Initial		DOCUMENT NUMBER	FILING DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION	
							YES	No
		2-148173	11/30/88	Japan			Abstract	X
		7-85099	9/20/93	Japan			Abstract	X

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Other Documents (Including Author, Title, Date Pertinent Pages, Etc.)

	Notice of Rejection dated July 8, 2003 from Japanese Patent Office
	Sadao ISHIDA, "Procedure for Multivariate Data Analysis by SPSS", April 24, 1998, pp. 172-181
	M.B. Eisen, P.T. Spellman et al., "Cluster Analysis and Display of Genome-Wide Expression Patterns", Proceeding of the National Academy of Sciences, December 1998, Vol. 95, pp. 14863-14868
EXAMINER	DATE CONSIDERED
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